Search Notes

Application/Control No.	Applicant(s) Reexaminat
10/617 386	NAKANO E

10/617,386 Examiner

Tom V. Sheng

Applicant(s)/Patent under Reexamination

NAKANO ET AL.

Art Unit

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SEARCHED					
Class	Subclass	Date	Examiner		
345	15/67	9/5/01	15		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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